

*Amendments to the Claims*

The following listing of claims will replace all prior versions and/or listings of claims in the application:

1. (Currently amended): A probe coming into contact with an electrode pad of a measurement object, comprising:

a connection terminal part integrally formed and connected to a substrate;

a probe support portion; and

a contact part, the contact part comprising

an edge part ~~part~~ having a tapered end configuration; and

~~a supporting part~~ contact support part which supports the ~~contact part~~ edge part and couple the edge part to the probe support part,

wherein the contact part ~~extending~~ extends from ~~an end of the~~ the probe supporting part ~~support part, and wherein the edge part~~ has a sectional configuration which shares at least one side face with the ~~supporting part~~ contact support part and wherein the edge part has a thickness that is less than the thickness of the contact support part.

2. (Original): The probe according to claim 1, wherein the contact part is formed of an electrically conductive material having superior electric characteristics.

3. (Original): The probe according to claim 1, wherein the contact part is formed of a metal material having elasticity.